



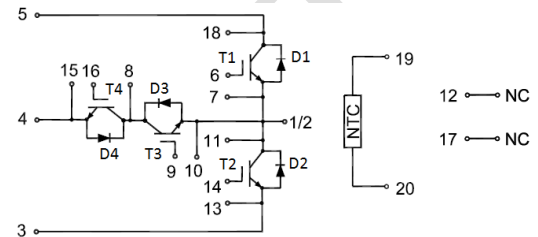
# GT400TT120A8H

## IGBT Module

### Features:

- Field Stop Trench Gate IGBT
- Short Circuit Rated >10 $\mu$ s
- Low Saturation Voltage
- Low Switching Loss
- 100% RBSOA Tested(2xIc)
- Low Stray Inductance
- Mixed Voltage Component Topology
- Lead Free, Compliant with RoHS Requirement

### Circuit Diagram



### Applications:

- Solar Applications
- UPS Systems

### IGBT, Buck Switch

#### Maximum Rated Values ( $T_C=25^{\circ}\text{C}$ unless otherwise specified)

$V_{CES}$	Collector-Emitter Blocking Voltage		1200	V
$V_{GES}$	Gate-Emitter Voltage		$\pm 20$	V
$I_C$	Continuous Collector Current	$T_C=100^{\circ}\text{C}$	400	A
		$T_C=25^{\circ}\text{C}$	800	A
$I_{CM}$	Repetitive Peak Collector Current	$T_J=175^{\circ}\text{C}$	800	A
$t_{sc}$	Short Circuit Withstand Time		>10	$\mu\text{s}$
$P_D$	Maximum Power Dissipation per IGBT	$T_C=25^{\circ}\text{C}$ $T_{Jmax}=175^{\circ}\text{C}$	2580	W



## Electrical Characteristics of IGBT ( $T_C=25^\circ\text{C}$ unless otherwise specified)

### Static Characteristics

Symbol	Description	Conditions	Min.	Typ.	Max.	Units
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=4\text{mA}$ , $V_{CE}=V_{GE}$	5.0	5.6	6.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=400\text{A}$ , $V_{GE}=15\text{V}$	$T_J=25^\circ\text{C}$	1.75	1.95	V
			$T_J=125^\circ\text{C}$	1.95		V
			$T_J=150^\circ\text{C}$	2.00		V
$I_{CES}$	Collector-Emitter Leakage Current	$V_{GE}=0\text{V}$ , $V_{CE}=V_{CES}$ , $T_J=25^\circ\text{C}$			1	mA
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_J=25^\circ\text{C}$			400	nA
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$		33.0		nF
$C_{oes}$	Output Capacitance			2.42		nF
$C_{res}$	Reverse Transfer Capacitance			1.35		nF

### Switching Characteristics

$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=600\text{V}$ , $I_C=400\text{A}$ , $R_{Gon}=1\Omega$ , $V_{GE}=\pm 15\text{V}$ , Inductive Load	$T_J=25^\circ\text{C}$		435		ns
			$T_J=125^\circ\text{C}$		446		
			$T_J=150^\circ\text{C}$		453		
$t_r$	Rise Time		$T_J=25^\circ\text{C}$		153		ns
			$T_J=125^\circ\text{C}$		167		
			$T_J=150^\circ\text{C}$		163		
$t_{d(off)}$	Turn-off Delay Time		$T_J=25^\circ\text{C}$		435		ns
			$T_J=125^\circ\text{C}$		465		
			$T_J=150^\circ\text{C}$		468		
$t_f$	Fall Time	$T_J=25^\circ\text{C}$		116		ns	
		$T_J=125^\circ\text{C}$		163			
		$T_J=150^\circ\text{C}$		181			
$E_{on}$	Turn-on Switching Loss	$V_{CC}=600\text{V}$ , $I_C=400\text{A}$ , $R_{Gon}=1\Omega$ , $V_{GE}=\pm 15\text{V}$ , $di/dt=2056\text{A}/\mu\text{s}$ ( $T_J=150^\circ\text{C}$ ) Inductive Load	$T_J=25^\circ\text{C}$		28.0		mJ
		$T_J=125^\circ\text{C}$		39.8			
		$T_J=150^\circ\text{C}$		42.7			



E <sub>off</sub>	Turn-off Switching Loss	V <sub>CC</sub> =600V, I <sub>C</sub> =400A, R <sub>Goff</sub> =1Ω, V <sub>GE</sub> =±15V, du/dt=3115V/μs ( T <sub>J</sub> =150°C) Inductive Load	T <sub>J</sub> =25°C	39.1	mJ
			T <sub>J</sub> =125°C	51.2	
			T <sub>J</sub> =150°C	54.6	
Q <sub>g</sub>	Total Gate Charge	V <sub>GE</sub> =+15V...-15V	T <sub>J</sub> =25°C	2.18	μC
R <sub>g internal</sub>	Internal gate resistance		T <sub>J</sub> =25°C	1.65	Ω
RBSOA	I <sub>C</sub> =800A, V <sub>CC</sub> =1050V, V <sub>p</sub> =1200V, R <sub>Goff</sub> = 1Ω, V <sub>GE</sub> =+15V to 0V, T <sub>J</sub> =125°C			Trapezoid	
I <sub>SC</sub>	V <sub>GE</sub> =±15V, V <sub>CC</sub> =600V, R <sub>Gon</sub> =1Ω, R <sub>Goff</sub> =1Ω, t <sub>p</sub> =10us, T <sub>J</sub> =150°C Inductive Load			1931	A
R <sub>θJC</sub>	IGBT Thermal Resistance: Junction-to-Case (per IGBT)			0.058	°C/W

## Buck Diode

### Maximum Rated Values (T<sub>C</sub>=25°C unless otherwise specified)

V <sub>RRM</sub>	Repetitive Peak Reverse Voltage	650	V
I <sub>F</sub>	Diode Continuous Forward Current	400	A
I <sub>FM</sub>	Diode Maximum Forward Current	800	A

### Electrical Characteristics of FWD (T<sub>C</sub>=25°C unless otherwise specified)

Symbol	Description	Conditions	Min.	Typ.	Max.	Units
V <sub>FM</sub>	Forward Voltage	I <sub>F</sub> =400A	T <sub>J</sub> =25°C	1.80		V
			T <sub>J</sub> =125°C	1.75		
			T <sub>J</sub> =150°C	1.75		
I <sub>rr</sub>	Peak Reverse Recovery Current		T <sub>J</sub> =25°C	59		A
			T <sub>J</sub> =125°C	108		
			T <sub>J</sub> =150°C	119		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =400A, di/dt =1500A/μs (T <sub>J</sub> =150°C), V <sub>rr</sub> =300V, V <sub>GE</sub> =-15V	T <sub>J</sub> =25°C	185		ns
			T <sub>J</sub> =125°C	268		
			T <sub>J</sub> =150°C	298		
Q <sub>rr</sub>	Reverse Recovery Charge		T <sub>J</sub> =25°C	6.9		μC
			T <sub>J</sub> =125°C	17.5		
			T <sub>J</sub> =150°C	21.1		



E <sub>rec</sub>	Reverse Recovery Energy	I <sub>F</sub> =400A, di/dt =1500A/μs (T <sub>J</sub> =150°C), V <sub>rr</sub> =300V, V <sub>GE</sub> =-15V	T <sub>J</sub> =25°C	1.3	mJ
			T <sub>J</sub> =125°C	3.5	
			T <sub>J</sub> =150°C	4.7	
R <sub>θJC</sub>	Diode Thermal Resistance: Junction-to-Case (per Diode)			0.179	°C/W

## IGBT, Boost Switch

### Maximum Rated Values (T<sub>C</sub>=25°C unless otherwise specified)

V <sub>CES</sub>	Collector-Emitter Blocking Voltage		650	V
V <sub>GES</sub>	Gate-Emitter Voltage		±20	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> =100°C	400	A
		T <sub>C</sub> =25°C	800	A
I <sub>CM</sub>	Repetitive Peak Collector Current	T <sub>J</sub> =175°C	800	A
t <sub>sc</sub>	Short Circuit Withstand Time		>5	μs
P <sub>D</sub>	Maximum Power Dissipation per IGBT	T <sub>C</sub> =25°C T <sub>Jmax</sub> =175°C	1640	W

### Electrical Characteristics of IGBT (T<sub>C</sub>=25°C unless otherwise specified)

#### Static Characteristics

Symbol	Description	Conditions	Min.	Typ.	Max.	Units
V <sub>GE(th)</sub>	Gate-Emitter Threshold Voltage	I <sub>C</sub> =9.6mA, V <sub>CE</sub> =V <sub>GE</sub>	5.0	5.9	6.5	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> =400A, V <sub>GE</sub> =15V	T <sub>J</sub> =25°C	1.60	1.90	V
			T <sub>J</sub> =125°C	1.65		V
			T <sub>J</sub> =150°C	1.65		V
I <sub>CES</sub>	Collector-Emitter Leakage Current	V <sub>GE</sub> =0V, V <sub>CE</sub> =V <sub>CES</sub>			1	mA
I <sub>GES</sub>	Gate-Emitter Leakage Current	V <sub>GE</sub> =±20V, V <sub>CE</sub> =0V			400	nA
C <sub>ies</sub>	Input Capacitance	V <sub>CE</sub> =25V, V <sub>GE</sub> =0V, f=100kHz		31.6		nF
C <sub>oes</sub>	Output Capacitance			1.93		nF
C <sub>res</sub>	Reverse Transfer Capacitance			1.32		nF



### Switching Characteristics

Symbol	Description	Conditions	Min.	Typ.	Max.	Units		
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=300V, I_C=400A,$ $R_{Gon}=2\Omega, V_{GE}=\pm 15V,$ Inductive Load	$T_J=25^\circ C$		410		ns	
			$T_J=125^\circ C$		437			
			$T_J=150^\circ C$		438			
$t_r$	Rise Time		$V_{CC}=300V, I_C=400A,$ $R_{Goff}=2\Omega, V_{GE}=\pm 15V,$ Inductive Load	$T_J=25^\circ C$		260		ns
				$T_J=125^\circ C$		255		
				$T_J=150^\circ C$		249		
$t_{d(off)}$	Turn-off Delay Time	$V_{CC}=300V, I_C=400A,$ $R_{Goff}=2\Omega, V_{GE}=\pm 15V,$ Inductive Load		$T_J=25^\circ C$		444		ns
				$T_J=125^\circ C$		429		
				$T_J=150^\circ C$		424		
$t_f$	Fall Time		$V_{CC}=300V, I_C=400A,$ $R_{Goff}=2\Omega, V_{GE}=\pm 15V,$ Inductive Load	$T_J=25^\circ C$		132		ns
				$T_J=125^\circ C$		167		
				$T_J=150^\circ C$		181		
$E_{on}$	Turn-on Switching Loss	$V_{CC}=300V, I_C=400A,$ $R_{Gon}=2\Omega, V_{GE}=\pm 15V,$ $di/dt=1340A/\mu s(T_J=150^\circ C),$ Inductive Load		$T_J=25^\circ C$		3.6		mJ
				$T_J=125^\circ C$		6.3		
				$T_J=150^\circ C$		6.8		
$E_{off}$	Turn-off Switching Loss		$V_{CC}=300V, I_C=400A,$ $R_{Goff}=2\Omega, V_{GE}=\pm 15V,$ $du/dt=2100V/\mu s(T_J=150^\circ C),$ Inductive Load	$T_J=25^\circ C$		14.0		mJ
				$T_J=125^\circ C$		27.8		
				$T_J=150^\circ C$		28.0		
$Q_g$	Total Gate Charge	$V_{GE}=+15V \dots -15V$		$T_J=25^\circ C$		2.24		$\mu C$
$R_{g\ internal}$	Internal Gate Resistor			$T_J=25^\circ C$		0		$\Omega$
RBSOA	$I_C=800A, V_{CC}=600V, V_p=650V, R_G=2\Omega, V_{GE}=+15V$ to 0V, $T_J=125^\circ C$				Trapezoid			
SCSOA	$V_{CC}=300V, t_p=10\mu s, V_{GE}=+/-15V, R_G=2\Omega, T_J=150^\circ C$		10				$\mu s$	
$R_{\theta JC}$	IGBT Thermal Resistance: Junction-to-Case (per IGBT)				0.091		$^\circ C/W$	



## Boost Diode

### Maximum Rated Values ( $T_C=25^{\circ}\text{C}$ unless otherwise specified)

$V_{RRM}$	Repetitive Peak Reverse Voltage	1200	V
$I_F$	Diode Continuous Forward Current	400	A
$I_{FM}$	Diode Maximum Forward Current	800	A

### Electrical Characteristics of Diode ( $T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Description	Conditions	Min.	Typ.	Max.	Units
$V_{FM}$	Forward Voltage	$I_F=400\text{A}$	$T_J=25^{\circ}\text{C}$	1.40		V
			$T_J=125^{\circ}\text{C}$	1.50		
			$T_J=150^{\circ}\text{C}$	1.45		
$t_{rr}$	Reverse Recovery Time		$T_J=25^{\circ}\text{C}$	0.46		$\mu\text{s}$
			$T_J=125^{\circ}\text{C}$	0.66		
			$T_J=150^{\circ}\text{C}$	0.74		
$I_{rr}$	Peak Reverse Recovery Current	$I_F=400\text{A}$ , $-diF/dt = 2380\text{A}/\mu\text{s}$ ( $T_J=150^{\circ}\text{C}$ ), $V_R=600\text{V}$ , $V_{GE}=-15\text{V}$	$T_J=25^{\circ}\text{C}$	263		A
			$T_J=125^{\circ}\text{C}$	300		
			$T_J=150^{\circ}\text{C}$	306		
$Q_{rr}$	Reverse Recovery Charge		$T_J=25^{\circ}\text{C}$	64		$\mu\text{C}$
			$T_J=125^{\circ}\text{C}$	101		
			$T_J=150^{\circ}\text{C}$	115		
$E_{rec}$	Reverse Recovery Energy		$T_J=25^{\circ}\text{C}$	28.9		mJ
			$T_J=125^{\circ}\text{C}$	44.8		
			$T_J=150^{\circ}\text{C}$	51.4		
$R_{\theta JC}$	Diode Thermal Resistance: Junction-to-Case (per Diode)				0.097	$^{\circ}\text{C}/\text{W}$



## Internal NTC-Thermistor Characteristics

R <sub>25</sub>	T <sub>C</sub> =25°C	5		kΩ
ΔR/R	T <sub>C</sub> =100°C, R <sub>100</sub> =481Ω		±5	%
P <sub>25</sub>	T <sub>C</sub> =25°C	10		mW
B <sub>25/50</sub>	$R_2=R_{25} \exp[B_{25/50}(1/T_2-1/(298.15K))]$	3380		K
B <sub>25/80</sub>	$R_2=R_{25} \exp[B_{25/80}(1/T_2-1/(298.15K))]$	3440		K

## Module

Symbol	Description	Min.	Typ.	Max.	Units
V <sub>ISO</sub>	Isolation Voltage (All Terminals Shorted) f=50Hz, 1minute	2500			V
Internal Isolation		Al <sub>2</sub> O <sub>3</sub>			
d <sub>creep</sub>	Creepage Distance: Terminal to Baseplate			25	mm
	Creepage Distance: Terminal to Terminal			12.5	mm
d <sub>clear</sub>	Clearance Distance: Terminal to Baseplate			11	mm
	Clearance Distance: Terminal to Terminal			7	mm
L <sub>SCE</sub>	Stray Inductance Module Measured between terminals 2 and 3			38	nH
T <sub>J</sub>	Maximum Junction Temperature			175	°C
T <sub>JOP</sub>	Maximum Operating Junction Temperature Range	-40		+150	°C
T <sub>stg</sub>	Storage Temperature	-40		+125	°C
CTI	Comparative Tracking Index	200			
R <sub>ecs</sub>	Case-to-Sink Thermally (Conductive Grease Applied)			0.03	°C/W
M	Power Terminals Screw:M6	3.0		6.0	N·m
M	Mounting Screw:M5	3.0		6.0	N·m
G	Weight		390		g



## Ordering Information Table

Device code	G	T	400	TT	120	A8	H
	①	②	③	④	⑤	⑥	⑦

- ① - IGBT Module
- ② - Trench, Low Switching Losses IGBT
- ③ - Rated Current (400=400A)
- ④ - Circuit Configuration (Three Level, T Type)
- ⑤ - Rated Voltage (120=1200V)
- ⑥ - Package Type
- ⑦ - Test Level (Pass the Important Reliability Test-Industrial Grade)

DATA SHEET



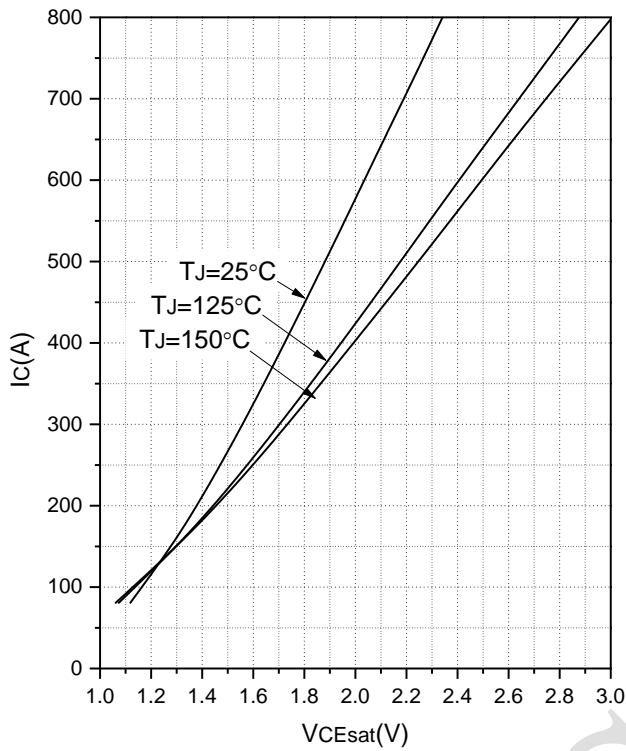


Fig.1 Typical Saturation Voltage Characteristics (Buck Switch)

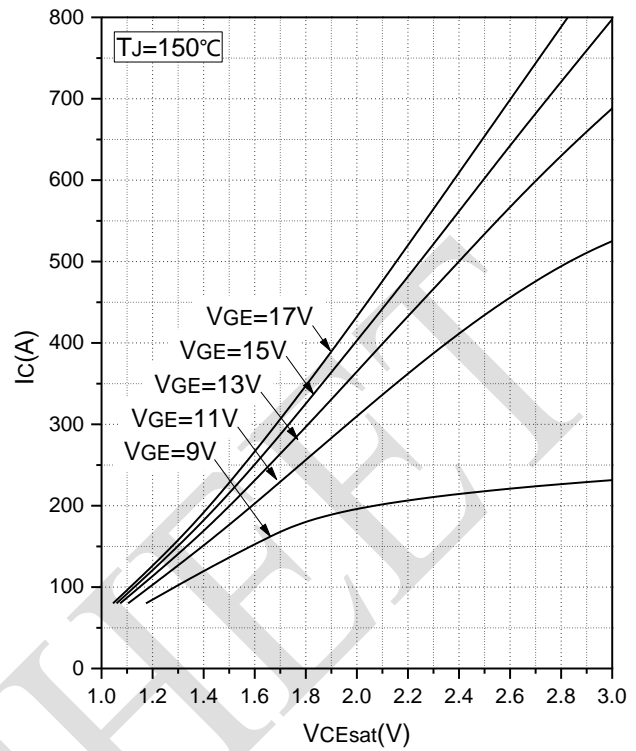


Fig.2 Typical Output Characteristics (Buck Switch)

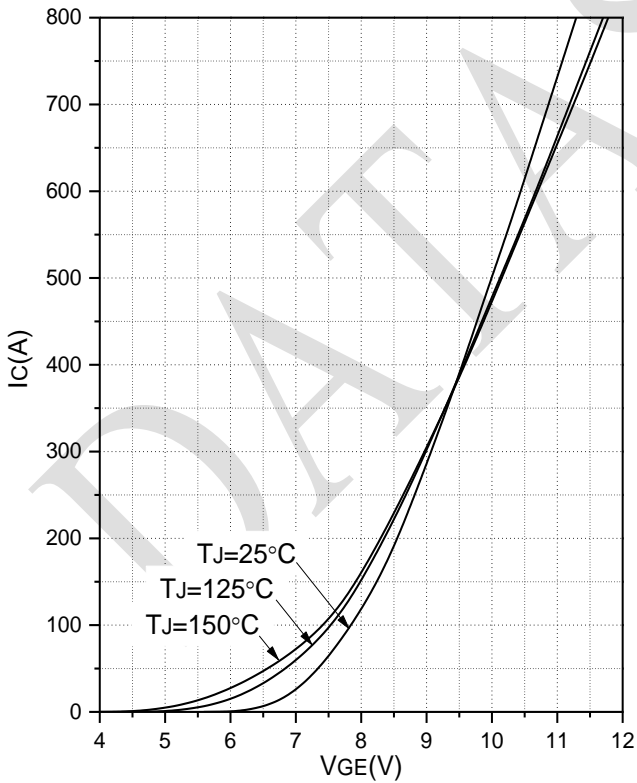


Fig.3 Transfer Characteristic (Buck Switch)

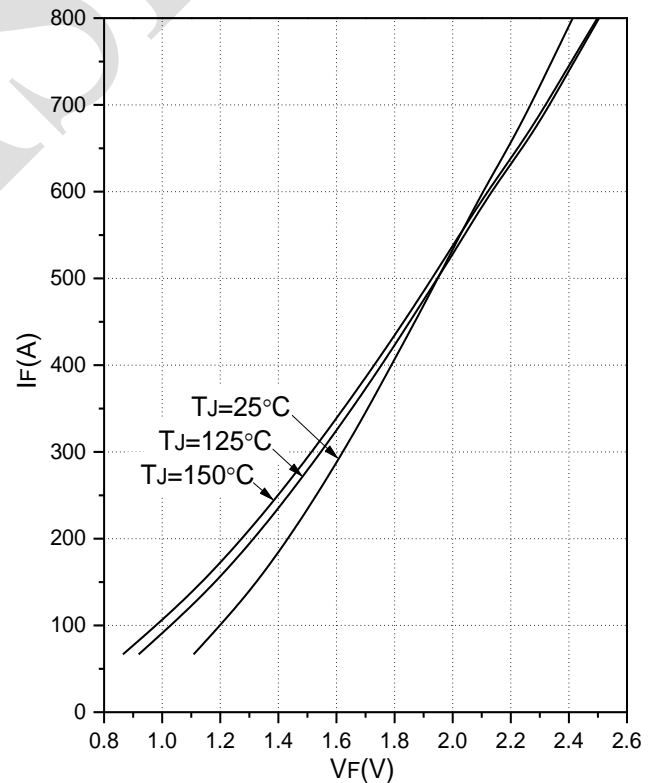


Fig.4 Forward Characteristics of Diode (Buck Diode)

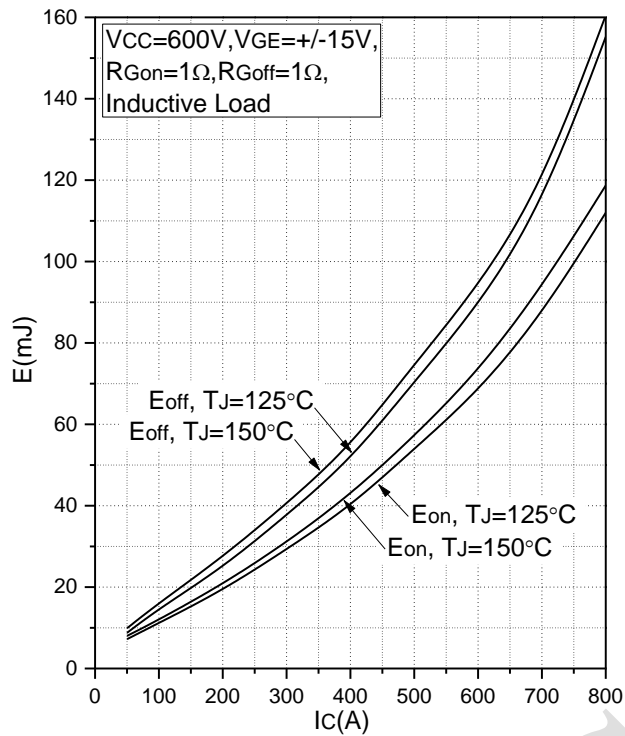


Fig.5 Typical Switching Loss vs. Collector Current (Buck Switch)

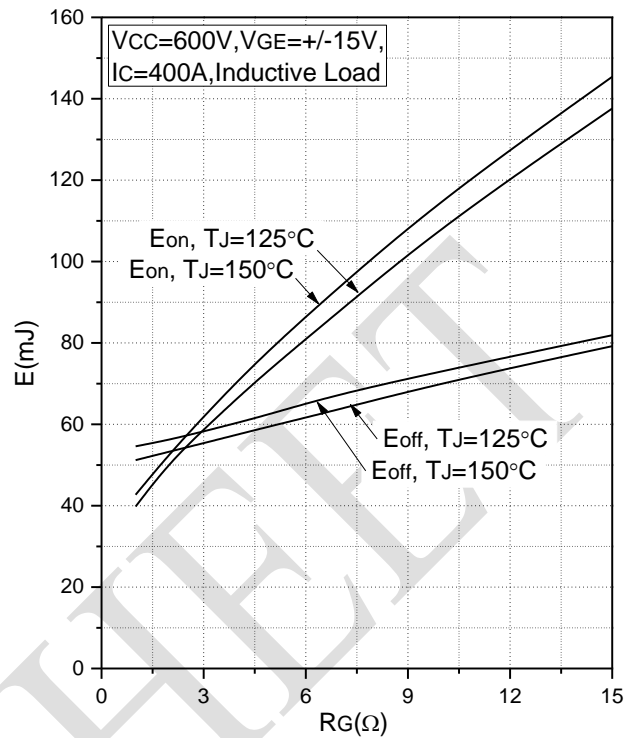


Fig.6 Typical Switching Loss vs. Gate Resistance (Buck Switch)

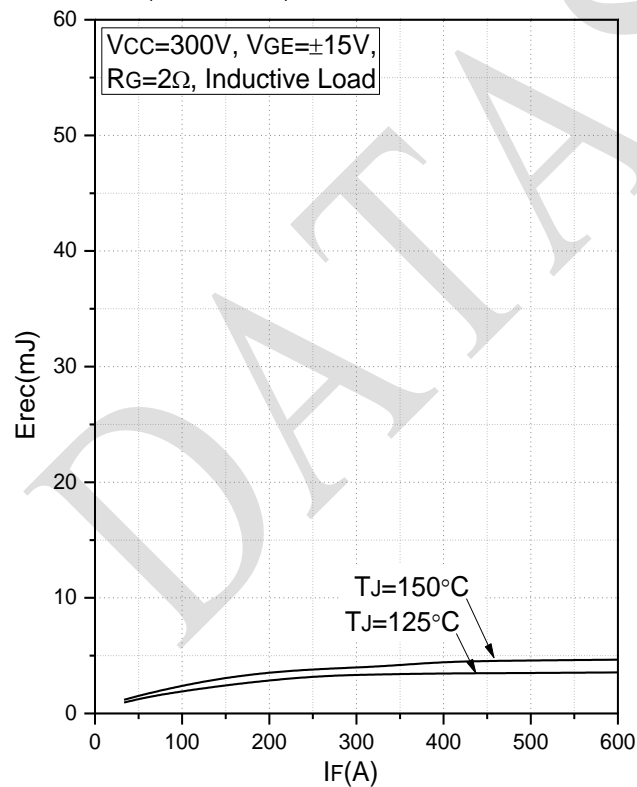


Fig.7 Typical Switching Loss vs. Forward Current (Buck Diode)

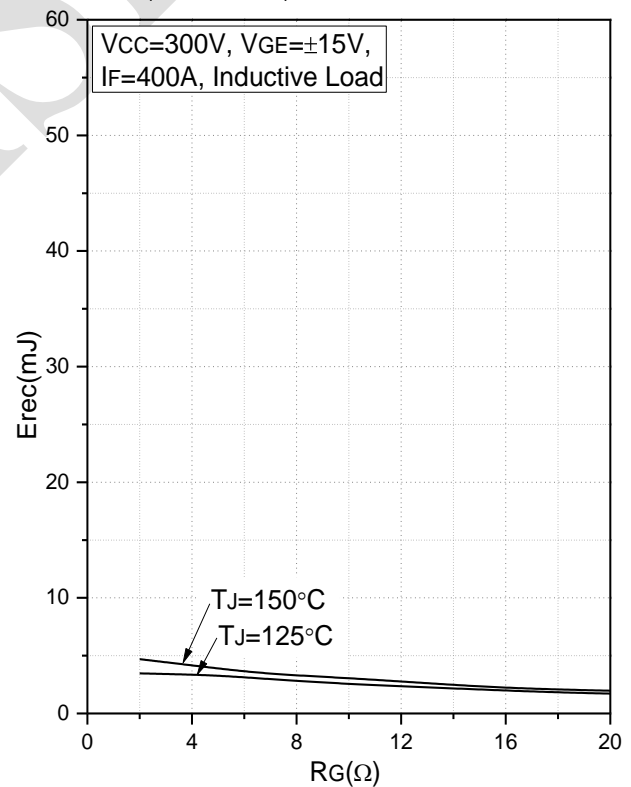


Fig.8 Typical Switching Loss vs. Gate Resistance (Buck Diode)

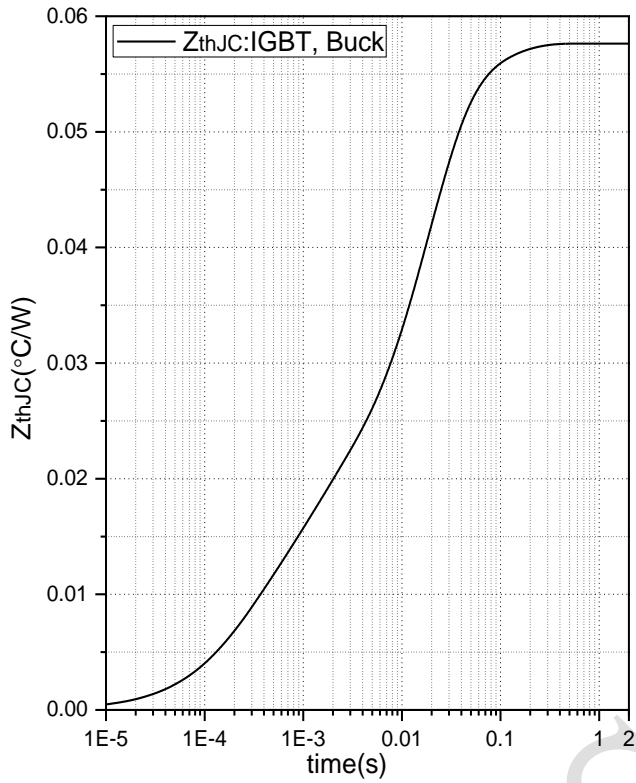


Fig.9 Transient Thermal Impedance (Buck Switch)

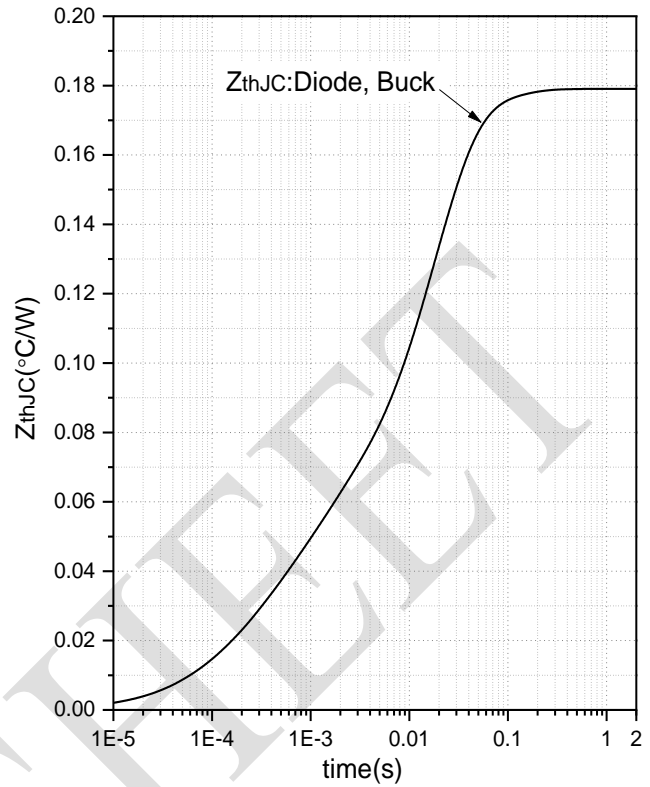


Fig.10 Transient Thermal Impedance (Buck Diode)

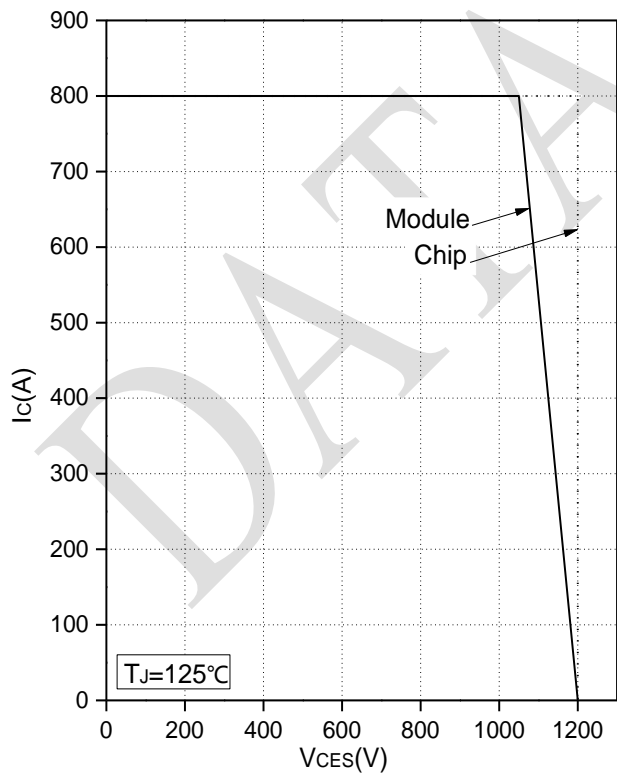


Fig.11 Reverse Bias Safe Operation Area (Buck Switch)

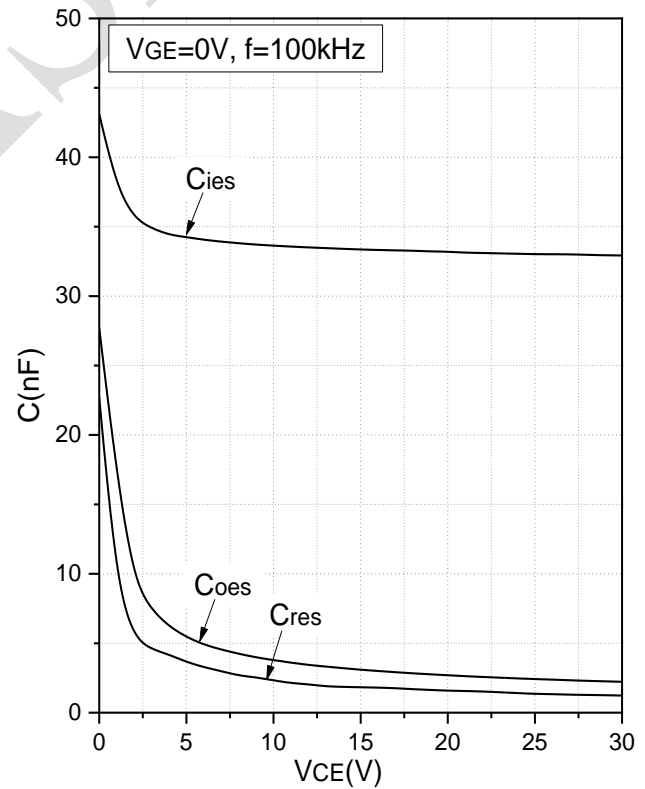


Fig.12 Capacitance Characteristics (Buck Switch)

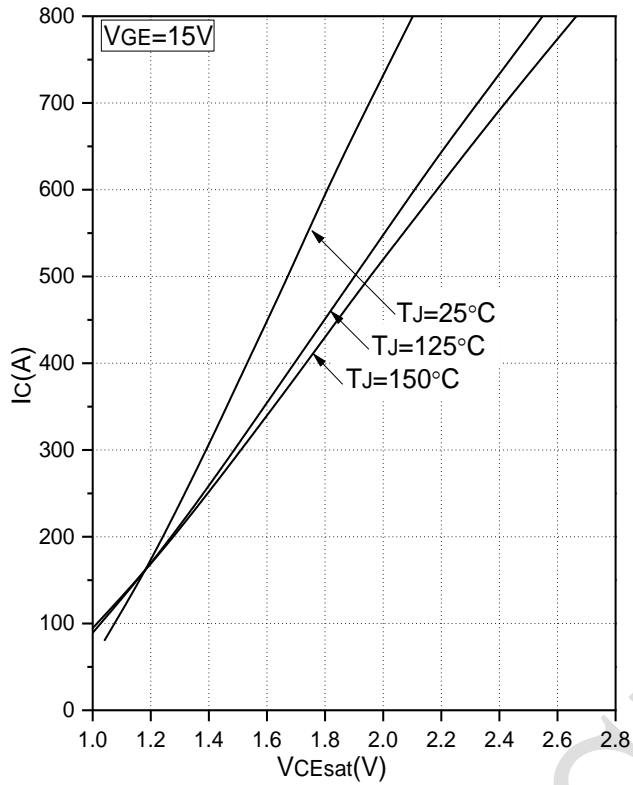


Fig.13 Typical Saturation Voltage Characteristics (Boost Switch)

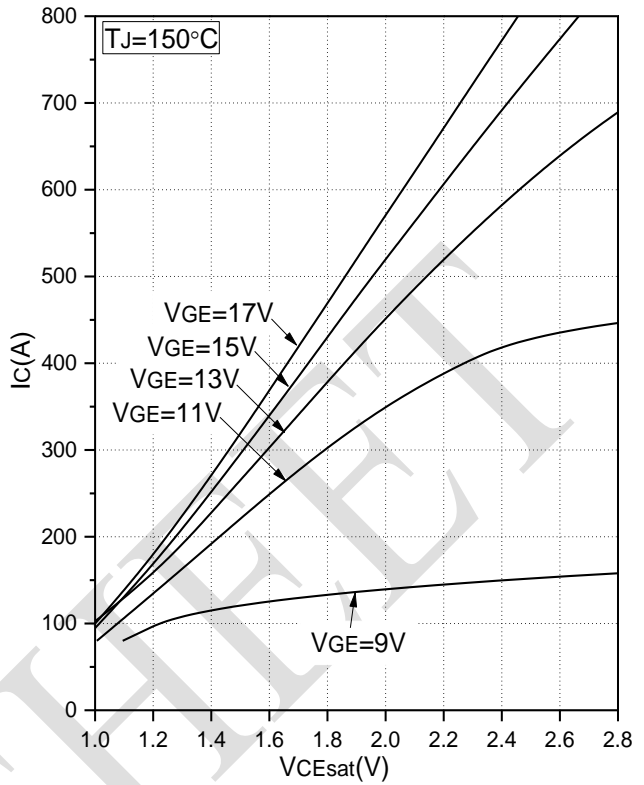


Fig.14 Typical Output Characteristics (Boost Switch)

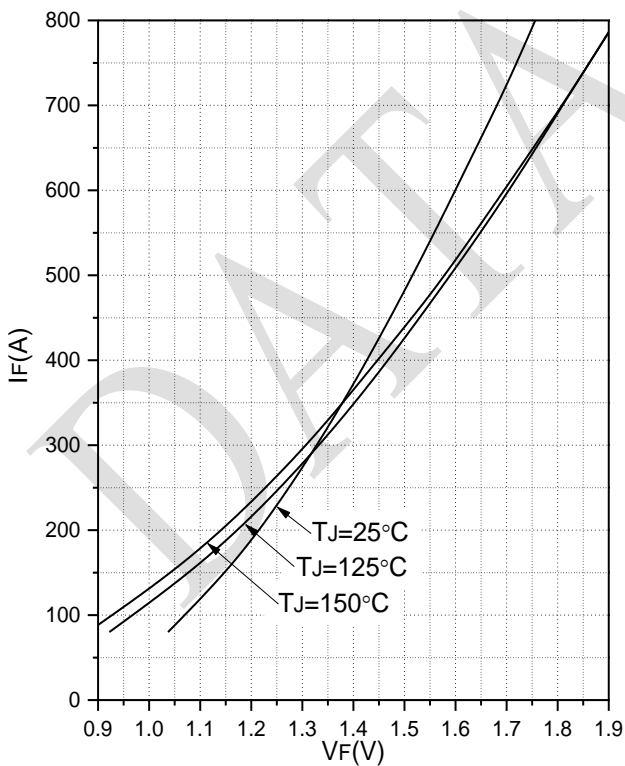


Fig.15 Forward Characteristics of Diode (Boost Diode)

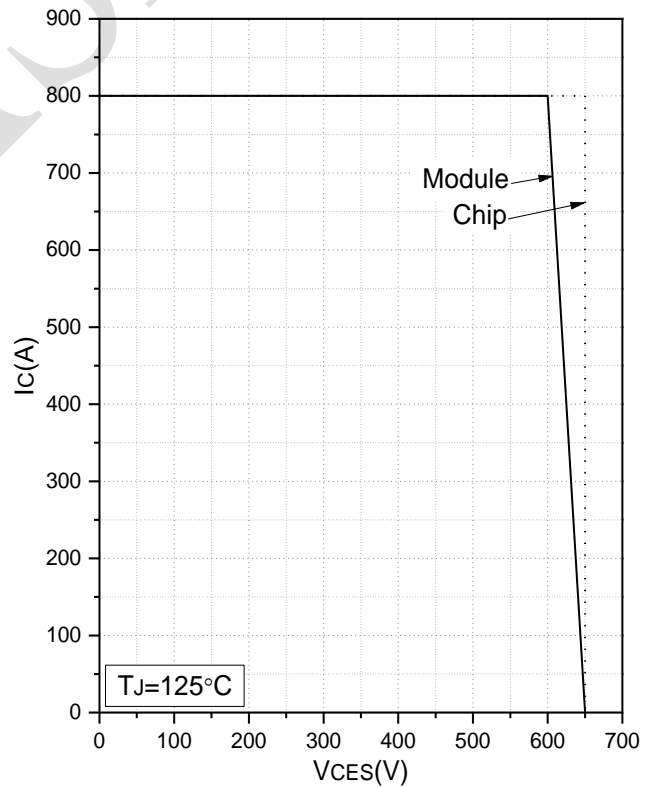


Fig.16 Reverse Bias Safe Operation Area (Boost Switch)

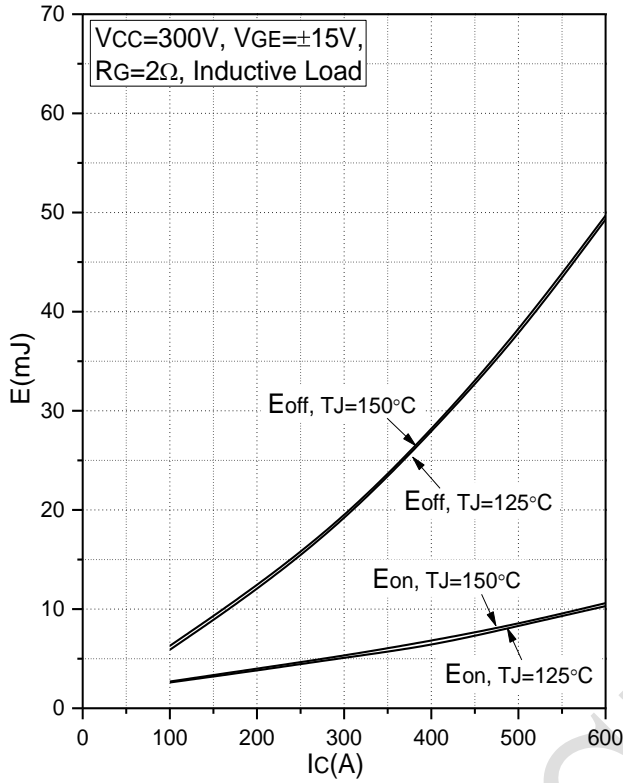


Fig. 17 Typical Switching Loss vs. Collector Current (Boost Switch)

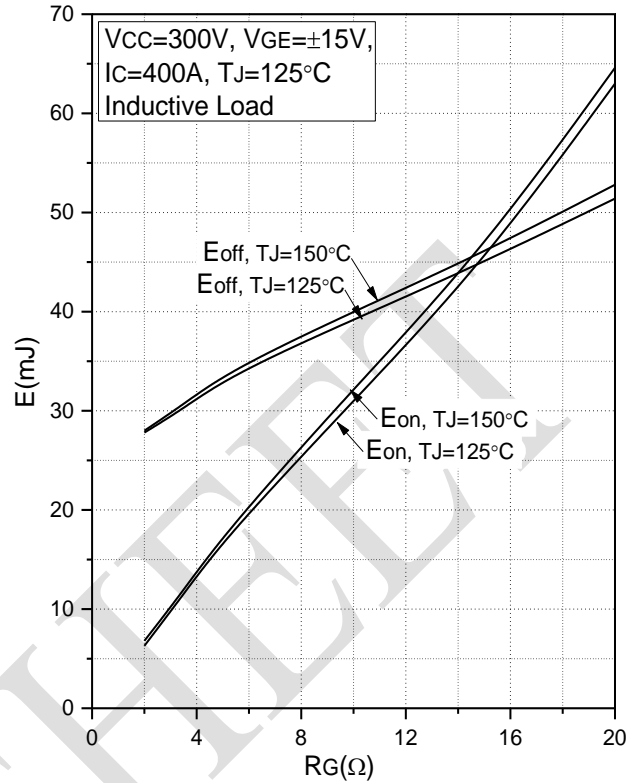


Fig. 18 Typical Switching Loss vs. Gate Resistance (Boost Switch)

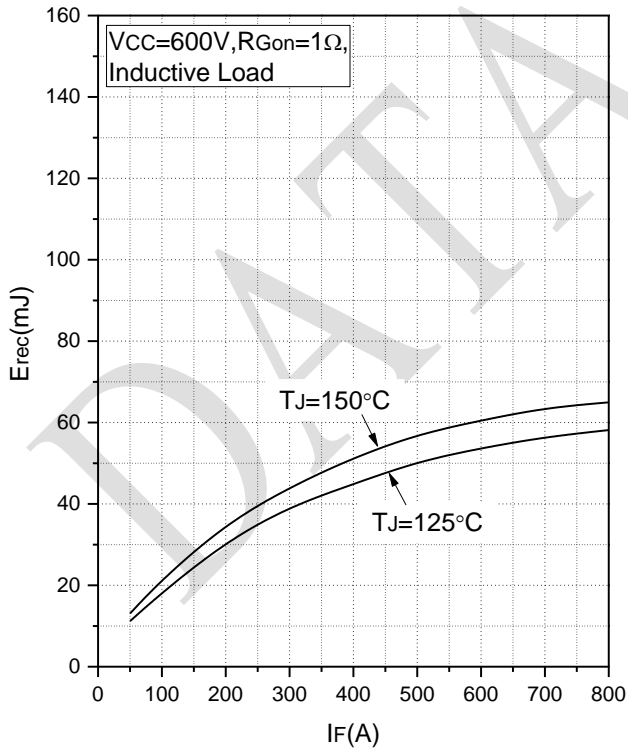


Fig. 19 Typical Switching Loss vs. Forward Current (Boost Diode)

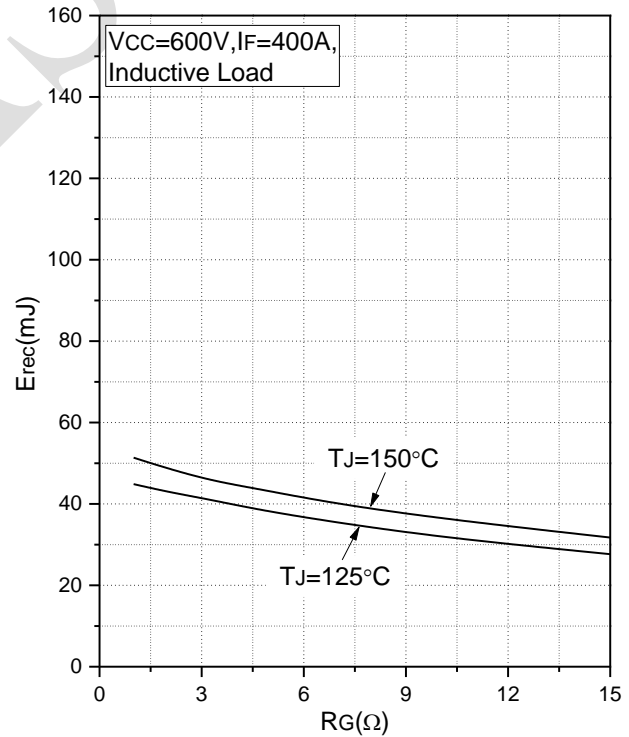


Fig. 20 Typical Switching Loss vs. Gate Resistance (Boost Diode)

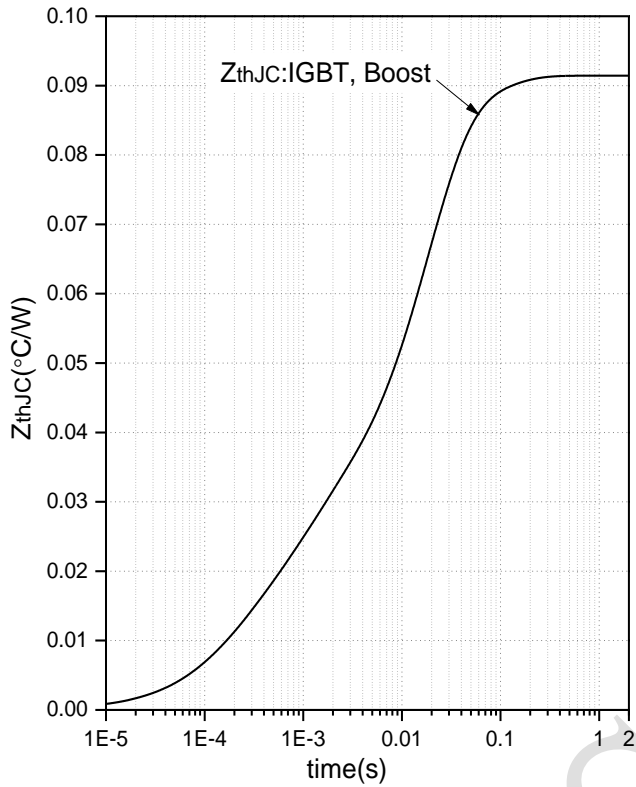


Fig.21 Transient Thermal Impedance (Boost Switch)

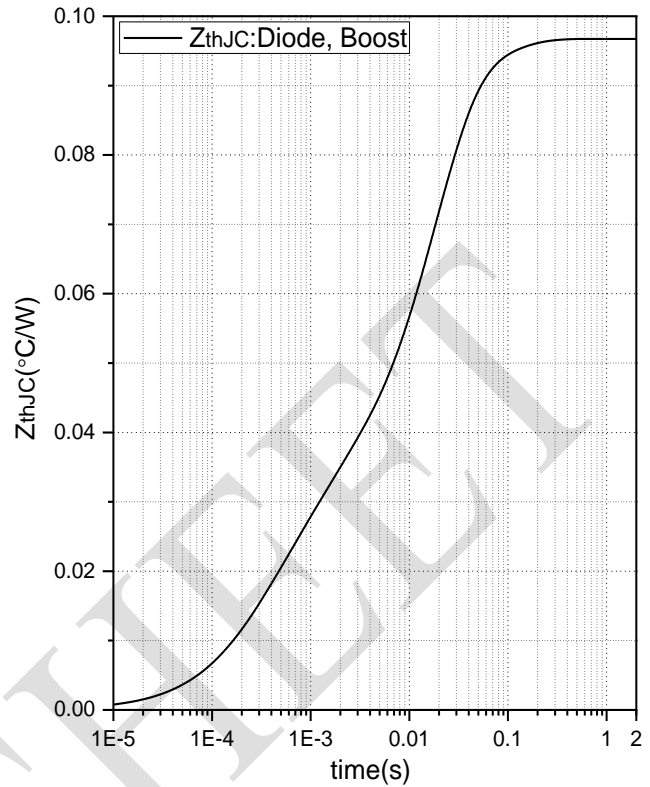


Fig.22 Transient Thermal Impedance (Boost Diode)

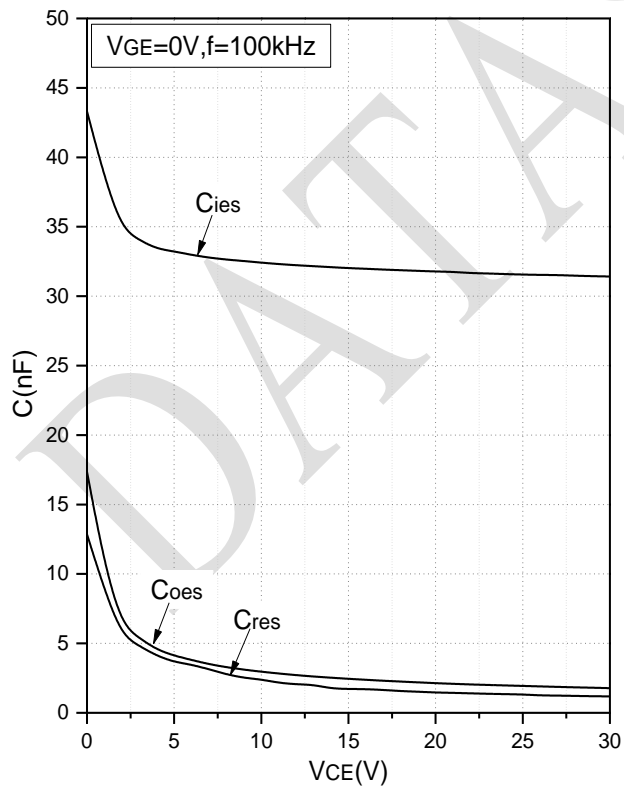


Fig.23 Capacitance Characteristics (Boost Switch)

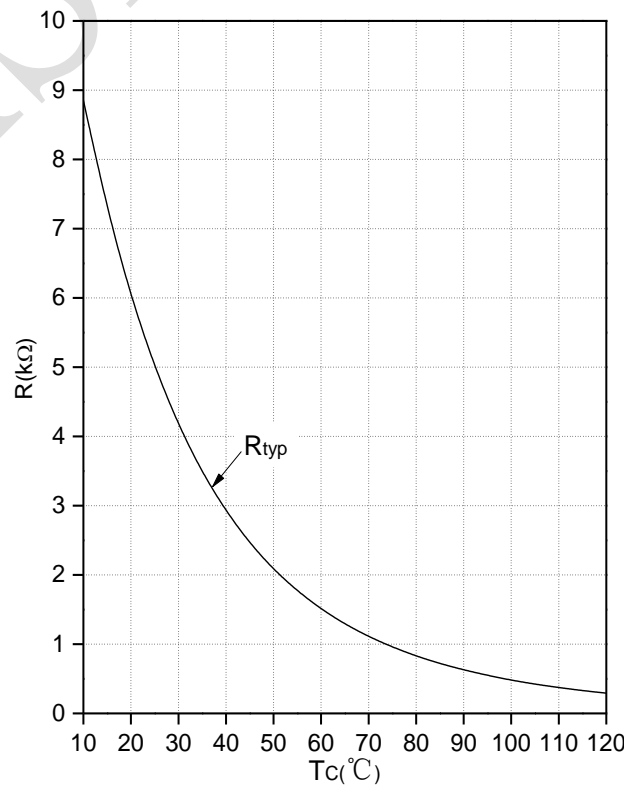
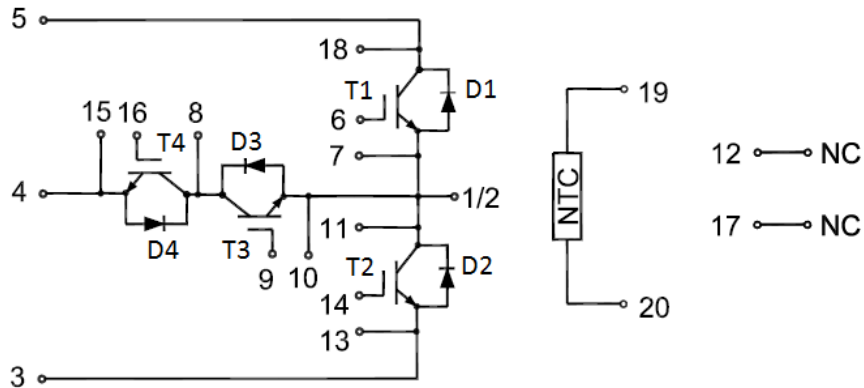


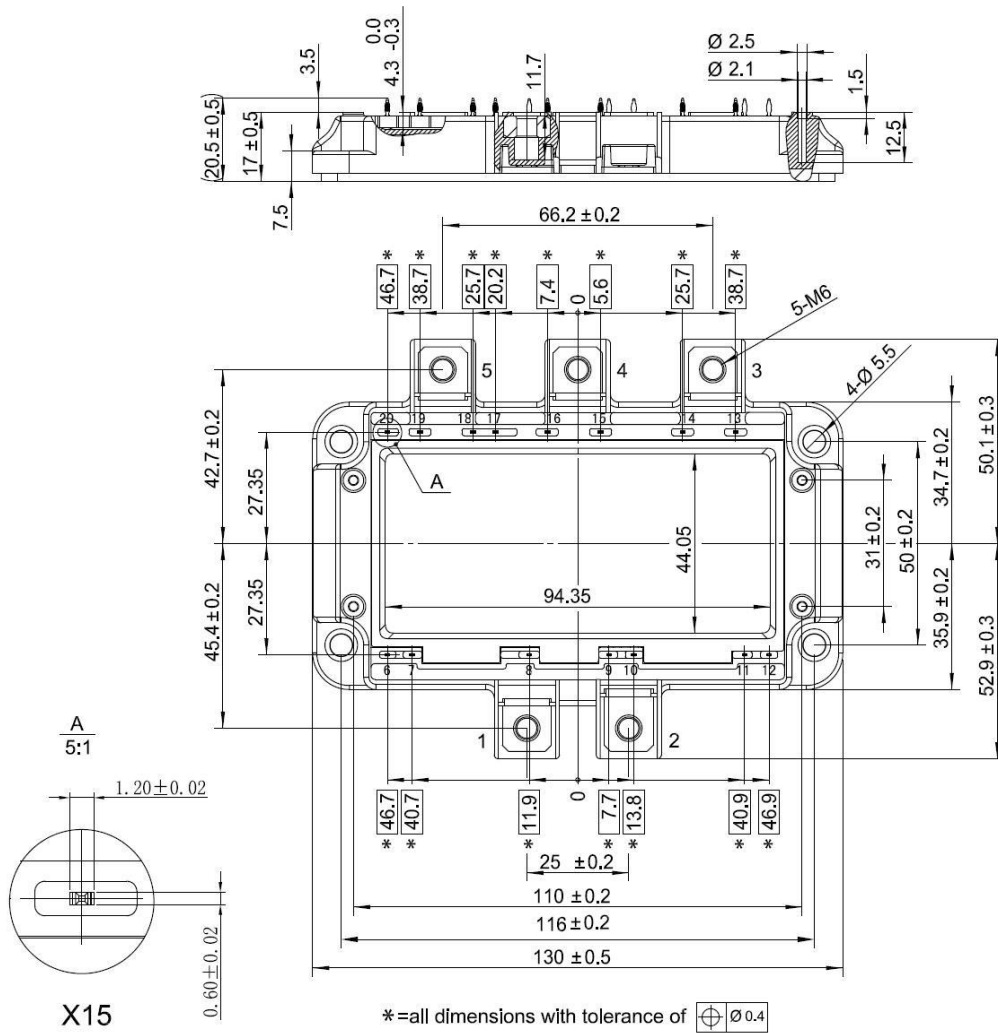
Fig.24 NTC Temperature Characteristics



### Internal Circuit



### Package Outline (Unit: mm):





Date	Revision	Notes
11/16/2022	A	Final Version

## Announcement

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The datasheet with “REV.” + “Arabic numerals” is based on engineering data for initial reference purpose only.

The released datasheet would be issued with “REV.” + “alphabet characters”.

DATA SHEET